

<b>Notice of References Cited</b>	Application/Control No. 10/784,767	Applicant(s)/Patent Under Reexamination ICHIKAWA, YUKIHITO	
	Examiner Ling X. Xu	Art Unit 1775	Page 1 of 1

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*	C	US-4,519,820	05-1985	Oyobe et al.	55/284
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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